TENTATIVE TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

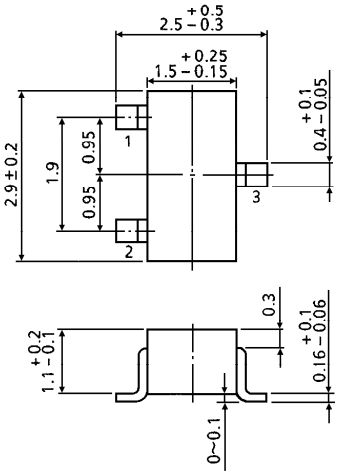
2SC5320

VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

(CHIP : f_T = 16GHz series)

- Low Noise Figure : NF = 1.4dB (f = 2GHz)
- High Gain : $|S_{21e}|^2$ = 10dB (f = 2GHz)

Unit in mm



1. BASE
2. EMITTER
3. COLLECTOR

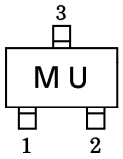
JEDEC	—
EIAJ	SC-59
TOSHIBA	2-3F1A

Weight : 0.012g

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	V_{CBO}	8	V
Collector-Emitter Voltage	V_{CEO}	5	V
Emitter-Base Voltage	V_{EBO}	1.5	V
Collector Current	I_C	10	mA
Base Current	I_B	5	mA
Collector Power Dissipation	P_C	150	mW
Junction Temperature	T_j	125	°C
Storage Temperature Range	T_{stg}	−55~125	°C

MARKING



MICROWAVE CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	f_T	V_{CE} = 3V, I_C = 7mA	9	—	—	GHz
Insertion Gain	$\|S_{21e}\|^2$ (1)	V_{CE} = 3V, I_C = 7mA, f = 1GHz	—	15.5	—	dB
	$\|S_{21e}\|^2$ (2)	V_{CE} = 3V, I_C = 7mA, f = 2GHz	—	10	—	
Noise Figure	NF (1)	V_{CE} = 3V, I_C = 3mA, f = 1GHz	—	0.9	1.8	dB
	NF (2)	V_{CE} = 3V, I_C = 3mA, f = 2GHz	—	1.4	2.3	

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	V_{CB} = 10V, I_E = 0	—	—	1	μA
Emitter Cut-off Current	I_{EBO}	V_{EB} = 1V, I_C = 0	—	—	1	μA
DC Current Gain	h_{FE}	V_{CE} = 3V, I_C = 7mA	50	—	250	V
Output Capacitance	C_{ob}	V_{CB} = 2.5V, I_E = 0, f = 1MHz	—	0.45	—	pF
Reverse Transfer Capacitance	C_{re}	(Note)	—	0.35	—	pF

(Note) C_{re} is measured by 3 terminal method with Capacitance bridge.

CAUTION

This device electrostatic sensitivity. Please handle with caution.

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